

(b) (5) DPP, (b) (7)(C), (b) (7)(D)

John C. Hong

3726

SEARCHED			
Class	Subclass	Date	Examiner
29	429	8/22/05	AN
	782		
	779		
	755		
	870		
	728		
	600		
	455.		
	450		
	453		
	510		
	516		
	520		
405	156		
	157		
	177		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

[illegible]

Search Notes (continued)



Application/Control No.

10/732,823

Examiner

John C. Hong

Applicant(s)/Patent under Reexamination

BJERKE ET AL.

Art Unit

3726

SEARCHED

Class	Subclass	Date	Examiner
140	71R	8/22/05	Sh
333	244	/	/
228	17.7		
	903		
138	112		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR